

TOSHIBA TRANSISTOR SILICON NPN TRIPLE DIFFUSED TYPE

# 2SC5354

HIGH SPEED AND HIGH VOLTAGE SWITCHING APPLICATIONS

SWITCHING REGULATOR APPLICATIONS

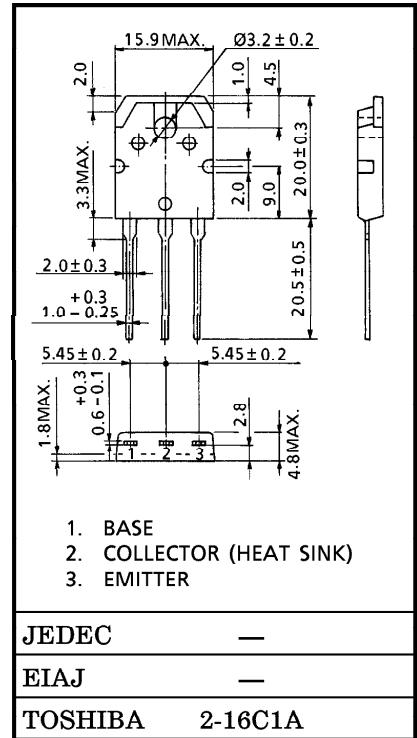
HIGH SPEED DC-DC CONVERTER APPLICATIONS

- Excellent Switching Times :  $t_r = 0.7\mu s$  (Max.)  
 $t_f = 0.5\mu s$  (Max.) ( $I_C = 2A$ )
- High Collector Breakdown Voltage :  $V_{CEO} = 800V$

MAXIMUM RATINGS ( $T_a = 25^\circ C$ )

CHARACTERISTIC		SYMBOL	RATING	UNIT
Collector-Base Voltage		$V_{CBO}$	900	V
Collector-Emitter Voltage		$V_{CEO}$	800	V
Emitter-Base Voltage		$V_{EBO}$	7	V
Collector Current	DC	$I_C$	5	A
	Pulse	$I_{CP}$	10	
Base Current		$I_B$	2	A
Collector Power Dissipation ( $T_c = 25^\circ C$ )		$P_C$	100	W
Junction Temperature		$T_j$	150	$^\circ C$
Storage Temperature Range		$T_{stg}$	-55~150	$^\circ C$

Unit in mm



Weight : 4.7g (Typ.)

961001FAA1

- TOSHIBA is continually working to improve the quality and the reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to observe standards of safety, and to avoid situations in which a malfunction or failure of a TOSHIBA product could cause loss of human life, bodily injury or damage to property. In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent products specifications. Also, please keep in mind the precautions and conditions set forth in the TOSHIBA Semiconductor Reliability Handbook.
- The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by TOSHIBA CORPORATION for any infringements of intellectual property or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any intellectual property or other rights of TOSHIBA CORPORATION or others.
- The information contained herein is subject to change without notice.

ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC		SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current		ICBO	V <sub>CB</sub> = 800V, I <sub>E</sub> = 0	—	—	100	μA
Emitter Cut-off Current		IEBO	V <sub>EB</sub> = 7V, I <sub>C</sub> = 0	—	—	1	mA
Collector-Base Breakdown Voltage		V (BR) CBO	I <sub>C</sub> = 1mA, I <sub>E</sub> = 0	900	—	—	V
Collector-Emitter Breakdown Voltage		V (BR) CEO	I <sub>C</sub> = 10mA, I <sub>B</sub> = 0	800	—	—	V
DC Current Gain		h <sub>FE</sub> (1)	V <sub>CE</sub> = 5V, I <sub>C</sub> = 10mA	10	—	—	
		h <sub>FE</sub> (2)	V <sub>CE</sub> = 5V, I <sub>C</sub> = 0.5A	15	—	—	
Collector-Emitter Saturation Voltage		V <sub>CE</sub> (sat)	I <sub>C</sub> = 2A, I <sub>B</sub> = 0.4A	—	—	1.0	V
Base-Emitter Saturation Voltage		V <sub>BE</sub> (sat)	I <sub>C</sub> = 2A, I <sub>B</sub> = 0.4A	—	—	1.3	V
Switching Time	Rise Time	t <sub>r</sub>	<p> <math>20\mu s</math> <math>V_{CC} \cong 400V</math>  <math>I_{B1}</math> <math>I_{B2}</math> <math>I_C = 4A</math>  <math>I_{B1} = 0.4A</math> <math>I_{B2} = -0.8A</math>                      DUTY CYCLE <math>\leq 1\%</math> </p>	—	—	0.7	μs
	Storage Time	t <sub>stg</sub>		—	—	4.0	
	Fall Time	t <sub>f</sub>		—	—	0.5	